

<b>Notice of References Cited</b>	Application/Control No. 09/872,848	Applicant(s)/Patent Under Reexamination KANG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,009,118	12-1999	Tiemann et al.	375/150
	B	US-			
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